

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Takatoshi Miyahara, et al.

Application No.: **Continuation of 09/807,005** Group Art Unit: N/A

Filed: July 23, 2003 Examiner: Not Yet Assigned

For: **METHOD OF AND DETECTING APARATUS
AND DETECTING CHIP FOR SINGLE BASE
SUBSTITUTION SNP AND POINT
MUTATION OF GENES**

PRELIMINARY AMENDMENT

MS Patent Application
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Prior to examination on the merits, please amend the above-identified U.S. patent application as shown below:

IN THE SPECIFICATION:

Please amend the specification as follows:

Page 8, please amend the last paragraph to read as follows:

Fig. 4, consisting of (a), (b) and (c), is a drawing showing the structure of the electrode and wiring, etc., of the detecting apparatus and the detecting chip of single base substitution SNP and point mutation of genes related to the present invention.